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<b>Substitute for form 1449A/B/PTO</b>  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)			<b>Complete if Known</b>		
			Application Number	10/671,123	
			Filing Date	September 24, 2003	
			First Named Inventor	Sebastian Schmidt	
			Art Unit	2812-2823	
			Examiner Name	Not Yet Assigned - W. William M. Brummer 5 To	
Sheet	1	of	1	Attorney Docket Number	INTECH 3.0-037 02 P 01514 US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
WB	AA	US-5,639,697	06-17-1997	Weling et al.	738/1132

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>3</sup>
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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
WB	CA	BRIAN LEE, DUANE S. BONING, DALE L. HETHERINGTON, DAVID J. STEIN, Using Smart Dummy Fill and Selective Reverse Etchback For Pattern Density Equalization, Proc. CMP-MIC, March, 2000, pages 255-258, Santa Clara, CA	

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Examiner Signature	William M. Brummer	Date Considered	18 SEP 04
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